

Subject 11296 - Transmission Electron

Microscopy

Group 1, 1S

Teaching guide A Language English

# Subject identification

**Subject** 11296 - Transmission Electron Microscopy

Credits 0.72 de presencials (18 hours) 2.28 de no presencials (57 hours) 3 de totals (75

hours).

**Group** Group 1, 1S (Campus Extens)

Teaching period 1st semester Teaching language English

**Professors** 

#### Horari d'atenció als alumnes

I	Troi un a acenció als alamnes						
Lecturers	Starting time	Finishing time	Day	Start date	Finish date	Office	
	12:00h	14:00h	Friday	02/02/2015	31/07/2015	F-308 Ed. Mateu	
Jaime Pons Morro jaume.pons@uib.es						Orfila, 3r. pis	
	12:00h	14:00h	Wednesday	02/02/2015	31/07/2015	F-308 Ed. Mateu	
						Orfîla, 3r. pis	
	17:30h	19:30h	Thursday	25/09/2014	17/07/2015	F114 - 1r	
						pis, Edifici	
Rubén Santamarta Martínez						Mateu Orfila	
ruben.santamarta@uib.es						(imprescindible	
						concertar cita	
						prèvia per email)	

#### Contextualisation

Transmission Electron Microscopy (TEM) is a powerful experimental technique for characterization of matter at microscopic scales, ranging from micrometers down to angstroms. This technique provides microstructural information of the object from magnified images, together with crystallographic information arising from the electron diffraction pattern. Moreover, additional spectroscopic techniques attached to the TEM instrument may give useful additional information, such as chemical composition with high spatial resolution (microanalysis). Due to these remarkable capabilities, the set of experimental techniques involved in TEM became an essential tool for the development of Life and Materials Sciences in the last half century. This course aims to provide the basic knowledge for the operation of a transmission electron microscope, combining the fundamentals of electron diffraction and image contrast with practical aspects related to the use of the instrument and to the correct interpretation of the large amount of information provided by this technique.

The course 11296 - Transmission Electron Microscopy belongs to the *Experimental Physics* module of the *Master's Degree in Advanced Physics and Applied Mathematics* at UIB, together with other experimental work related subjects. However, the specific nature of this subject creates a direct link with the *Materials Physics* module too. The subject is also included in the *Chemistry and Physics of Materials Speciality* of the *Master's Degree in Chemical Science and Technology* at UIB.



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The academic and research background of the lecturers fit perfectly with the topic of the subject. Rubén Santamarta received his PhD in Physics at UIB in 2002. He is a member of the Physics of Materials research group and Associate Professor since 2005, with teaching activity both in undergraduate and graduate levels (Master's degree and PhD program courses). Between 2002 and 2004 held a post-doctoral stay at EMAT (Antwerp, Belgium) to improve his skills in TEM. This is one of the top electron microscopy centers in Europe. Jaume Pons received his PhD in Physics in 1992 and performed a post-doc stay at the Centre d'Etudes de Chimie Metallurgique - CNRS (France) in 1993 for specialization in High Resolution TEM. He became Associate Professor in 1994 and Professor of Applied Physics in 2011. His research activity has always been in the Physics of Materials research group. Both lecturers are experienced users of electron microscopy and diffraction techniques since their PhD work. During these years, more than 120 scientific papers published by these authors in indexed international journals have included results obtained by TEM and related techniques.

## Requirements

## Essential requirements

Degree in Sciences or Engineering

### Recommendable

For those students with no background on electron microscopy techniques, it is strongly recommended to take the subject 11280-Structural and Microstructural Characterization of Materials from the Physics of Materials' Module. The 11280 subject provides the basic concepts of electron microscopy and diffraction which are needed for a proper comprehension of the 11296 - Transmission Electron Microscopy subject.

# **Skills**

## Specific

- \* CE3 To adquire edge-line knowledge in the international scientific research context and demostrate a full comprehension of theoretical and practical aspects, together with the scientific methodology.
- \* EX8 To know the posibilities and limitations of the Transmission Electron Microscopy techniques and adquire skills to analyze and extract information from the rough results provided by the instrument..

# Generic

\* CG1 - Sistematic comprehension of a field of knowledge and its related skills and research methods...



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### **Basic**

\* You may consult the basic competencies students will have to achieve by the end of the Master's degree at the following address: <a href="http://estudis.uib.cat/master/comp">http://estudis.uib.cat/master/comp</a> basiques/

#### Content

## Theme content

1.. Introduction

General introduction to the instrument and interaction of electrons with matter

2.. Sample Preparation

Electropolishing, ion milling, FIB, deposition of nanometric samples

3.. Electron Diffraction

Dynamical Theory of Electron Diffraction. Different approaches: Wave-Optical formulation and Howie-Whelan equations. Quantum Mechanical formulation and Bloch waves. Inelastic scattering and Kikuchi patterns

4.. Imaging in the TEM

Principles of Image Contrast. Thickness and bending effects. Crystal defects contrast: dislocations and planar defects. Strain fields. Dark-field microscopy

5.. High Resolution TEM

Phase contrast. Weak-phase object aproximation. Transfer function and Scherzer defocuss. Simulation of HRTEM images. Filtering HRTEM images.

6.. Spectroscopic Techniques

X-ray spectroscopy microanalysis (EDX-WDX). Electron Energy Loss Spectroscopy (EELS).

7.. Advanced Techniques

Scanning-Transmission Electron Microscopy (STEM): Annular Dark Field (ADF), High Angle Annular Dark field (HAADF) and Z contrast. Energy Filtering Microscopy. Aberration Corrected Microscopy.

# Teaching methodology

# In-class work activities

Modality	Name	Typ. Grp.	Description	Hours
Theory classes	Theory classes	Large group (G)	Master classes to introduce the theoretical basis of the course content.	11
Laboratory classes	Laboratory	Medium group (M	) Lab activity about sample preparation, operation of the instrument and image simulations. Most of this work will be performed at the Scientific and Technical facilities Service of the UIB, under the lecturer supervision.	;
			ine Orb, under the recturer supervision.	2

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Modality	Name	Typ. Grp.	Description	Hours
Assessment	Oral presentation	Large group (G)	Oral presentation about a proposed theme.	1
Assessment	Short exams	Large group (G)	Written exams composed of short questions about concepts developed in the classes	the 1

At the beginning of the semester a schedule of the subject will be made available to students through the UIBdigital platform. The schedule shall at least include the dates when the continuing assessment tests will be conducted and the hand-in dates for the assignments. In addition, the lecturer shall inform students as to whether the subject work plan will be carried out through the schedule or through another way included in the Campus Extens platform.

## Distance education work activities

Modality	Name	Description	Hours
Individual self- study	Report	Preparation of a written report on a proposed topic.	37
Individual self- study	Study	Study of the concepts developed in the classes	20

## Specific risks and protective measures

The learning activities of this course do not entail specific health or safety risks for the students and therefore no special protective measures are needed.

## Student learning assessment

Theory	classes	

Modality Theory classes

Technique Attitude scales (non-retrievable)

Master classes to introduce the theoretical basis of the course content. Description

Assessment criteria Attitude and participation in the classes

Final grade percentage: 5%



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#### Laboratory

Modality Laboratory classes

Technique Attitude scales (non-retrievable)

Description Lab activity about sample preparation, operation of the instrument and image simulations. Most of this work

will be peformed at the Scientific and Technical facilities Service of the UIB, under the lecturer supervision.

Assessment criteria Attitude and participation in the classes

Final grade percentage: 5%

### **Oral presentation**

Modality Assessment

Technique Oral tests (retrievable)

Description Oral presentation about a proposed theme.

Assessment criteria Oral presentation of the report.

Final grade percentage: 25%

### Short exams

Modality Assessment

Technique Short-answer tests (retrievable)

Description Written exams composed of short questions about the concepts developed in the classes

Assessment criteria

Written exams composed of short questions about the concepts developed in the classes

Final grade percentage: 25%

### Report

Modality Individual self-study

Technique Papers and projects (retrievable)

Description Preparation of a written report on a proposed topic.

Assessment criteria Written report about a proposed topic

Final grade percentage: 40%

## Resources, bibliography and additional documentation

### **Basic bibliography**

D.B. Williams, C. B. Carter. Transmission Electron Microscopy: a textbook for materials science. Plenum Press (1996).

### Complementary bibliography

- P. Hirsch, A. Howie, R.B. Nicholson, D.W. Pashley, M.J. Whelan. Electron Microscopy of Thin Crystals. Robert Krieger Publishing Co. (1977)
- L. Reimer. Transmission Electron Microscopy : Physics of image formation and microanalysis. 2nd Ed. Springer-Verlag (1989)

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- M. de Graef. Introduction to Conventional Transmission Electron Microscopy. Cambridge univ. Press (2002)